

Notice of References Cited	Application/Control No. 10/541,759	Applicant(s)/Patent Under Reexamination MIYAO ET AL.	
	Examiner Hae M. Hyeon	Art Unit 2839	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,652,154	11-2003	Shirakawa et al.	385/70
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NON-PATENT DOCUMENTS

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